

<b>Notice of References Cited</b>	Application/Control No. 09/784,141	Applicant(s)/Patent Under Reexamination OIKAWA ET AL.	
	Examiner Christopher R. Magee	Art Unit 2653	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,287,237 A	02-1994	Kitada et al.	360/327.32
	B	US-6,358,379 B1	03-2002	Kouchiyama, Akira	204/192.2
	C	US-US200100158878	08-2001	Varga et al.	360/324.12
	D	US-6,025,978 A	02-2000	Hoshi et al.	360/319
	E	US-6,687,082 B1	02-2004	Ishiwata et al.	360/126
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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